

LM5538/LM7538 and LM5539/LM7539
electrical characteristics

LM5538/LM5539: The following apply for $-55^{\circ}\text{C} \leq T_A \leq 125^{\circ}\text{C}$, $V^+ = 5\text{V} \pm 5\%$, $V^- = -5\text{V} \pm 5\%$ (Note 1)

PARAMETER	MIN	TYP	MAX	UNIT	TEST CONDITIONS (EACH AMPLIFIER)					
					DIFF. INPUT	REF. INPUT	STROBE INPUT	LOGIC OUTPUT	SUPPLY VOLT.	COMMENTS
Differential Input Threshold Voltage (V_{TH}) (Note 2)	10(8) 35(33)	15	20(22) 45(47)	mV	$\pm V_{TH}$	15 mV	+5V	+5.25V	$\pm 5V \pm 5\%$	Logic Output <250 μA
		15		mV	$\pm V_{TH}$	15 mV	+5V	+20 mA	$\pm 5V \pm 5\%$	Logic Output <0.4V
		40		mV	$\pm V_{TH}$	40 mV	+5V	+5.25V	$\pm 5V \pm 5\%$	Logic Output <250 μA
		40		mV	$\pm V_{TH}$	40 mV	+5V	+20 mA	$\pm 5V \pm 5\%$	Logic Output <0.4V
Differential & Reference Input Bias Current		30	100	μA	0V	0V	+5.25V		$\pm 5.25V$	

LM7538/LM7539: The following apply for $0^{\circ}\text{C} \leq T_A \leq 70^{\circ}\text{C}$, $V^+ = 5\text{V} \pm 5\%$, $V^- = -5\text{V} \pm 5\%$

Differential Input Threshold Voltage (V_{TH}) (Note 3)	11(8) 36(33)	15	19(22) 44(47)	mV	$\pm V_{TH}$	15 mV	+5V	+5.25V	$\pm 5\text{V} \pm 5\%$	Logic Output <250 μA	Logic Output <0.4V Logic Output <250 μA Logic Output <0.4V
		15		mV	$\pm V_{TH}$	15 mV	+5V	+20 mA	$\pm 5\text{V} \pm 5\%$	Logic Output <0.4V	
		40		mV	$\pm V_{TH}$	40 mV	+5V	+5.25V	$\pm 5\text{V} \pm 5\%$	Logic Output <250 μA	
		40		mV	$\pm V_{TH}$	40 mV	+5V	+20 mA	$\pm 5\text{V} \pm 5\%$	Logic Output <0.4V	
Differential & Reference Input Bias Current		30	75	μA	0V	0V	+5.25V		$\pm 5.25\text{V}$		

LM5538/LM5539: The following apply for $-55^{\circ}\text{C} \leq T_A \leq 125^{\circ}\text{C}$, $V^+ = 5\text{V} \pm 5\%$, $V^- = -5\text{V} \pm 5\%$

LM7538/LM7539: The following apply for $0^{\circ}\text{C} \leq T_A \leq 70^{\circ}\text{C}$, $V^+ = 5\text{V} \pm 5\%$, $V^- = -5\text{V} \pm 5\%$

Diff. Input Offset Current	2	0.5		μA	0V	0V	+5.25V		$\pm 5.25\text{V}$	Logic Output <0.4V Logic Output <250 μA
Logic "1" Input Voltage				V	40 mV	20 mV	+2V	+20 mA	$\pm 4.75\text{V}$	
Logic "0" Input Voltage			0.8	V	40 mV	20 mV	+0.8V	+5.25V	$\pm 4.75\text{V}$	
Logic "0" Input Current		-1	-1.6	mA	40 mV	20 mV	+0.4V		$\pm 5.25\text{V}$	
Logic "1" Input Current		5	40	μA	0V	20 mV	+2.4V		$\pm 5.25\text{V}$	
Logic "1" Input Current		0.02	1	mA	0V	20 mV	+5.25V		$\pm 5.25\text{V}$	
Logic "0" Output Voltage		0.25	0.40	V	40 mV	20 mV	+2.0V	+20 mA	$\pm 4.75\text{V}$	
Output Leakage Current		0.01	250	μA	40 mV	20 mV	+0.8V	+5.25V	$\pm 4.75\text{V}$	
V^+ Supply Current		28	38	mA	0V	20 mV	0V		$\pm 5.25\text{V}$	
V^- Supply Current		-13	-18	mA	0V	20 mV	0V		$\pm 5.25\text{V}$	

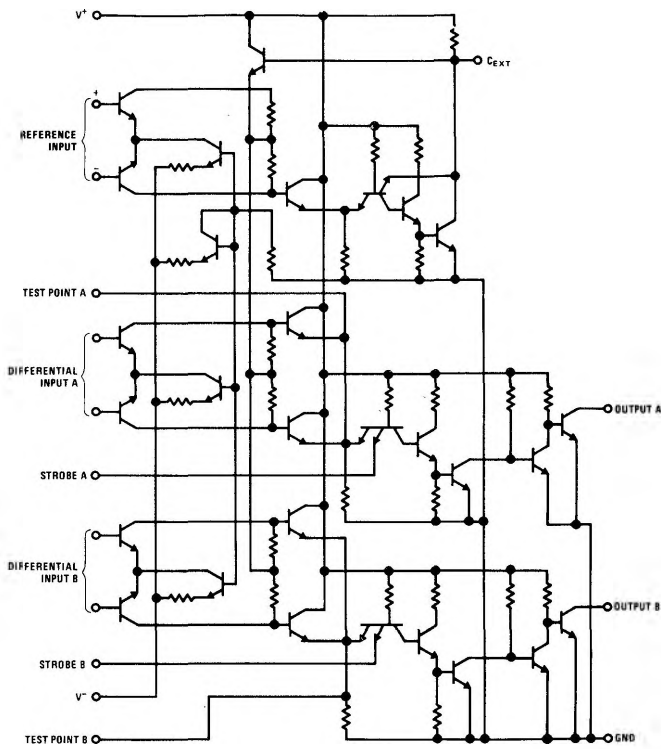
LM5538/LM5539 and LM7538/LM7539: The following apply for $T_A = 25^{\circ}\text{C}$, $V^+ = 5\text{V}$, $V^- = -5\text{V}$

AC Common-Mode Input Firing Voltage		± 2.5		V	PULSE	20 mV	+5V	SCOPE		
Propagation Delays:										
Differential Input to Logical "1" Output		24		ns		20 mV				AC Test Circuit
Differential Input to Logical "0" Output		20	40	ns		20 mV				AC Test Circuit
Strobe Input to Logical "1" Output		16		ns		20 mV				AC Test Circuit
Strobe Input to Logical "0" Output		10	30	ns		20 mV				AC Test Circuit
Differential Input Overload Recovery Time		10		ns						
Common-Mode Input Overload Recovery Time		5		ns						
Min. Cycle Time		200		ns						

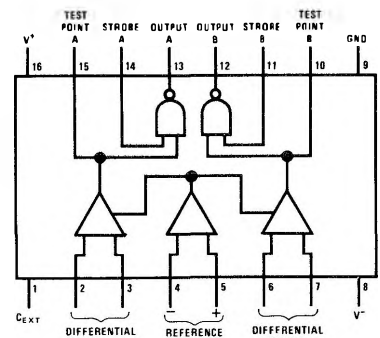
- Note 1: For $0^{\circ}\text{C} \leq T_A \leq 70^{\circ}\text{C}$ operation, electrical characteristics for LM5538 and LM5539 are guaranteed the same as LM7538 and LM7539 respectively.
- Note 2: Limits in parentheses pertain to LM5539, other limits pertain to LM5538.
- Note 3: Limits in parentheses pertain to LM7539, other limits pertain to LM7538.
- Note 4: Positive current is defined as current into the referenced pin.
- Note 5: Pin 1 to have $\geq 100\text{ pF}$ capacitor connected to ground.
- Note 6: Each test point to have $\leq 15\text{ pF}$ capacitive load to ground.

LM5538/LM7538 and LM5539/LM7539

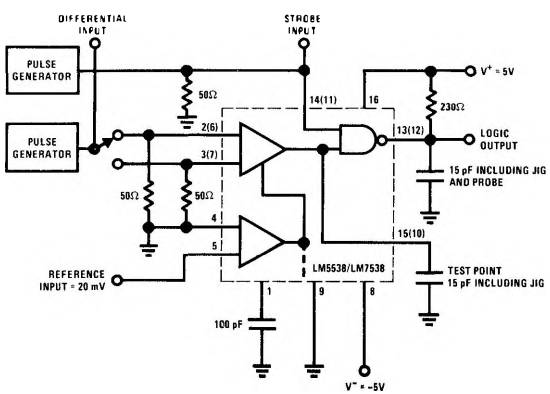
schematic diagram



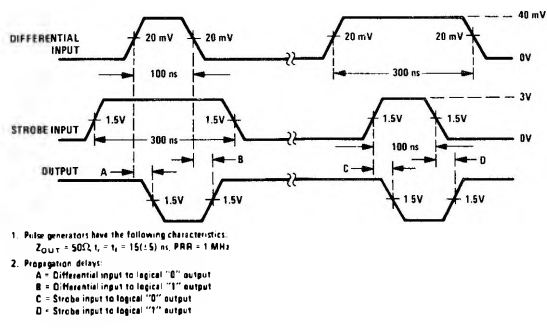
connection diagram



AC test circuit

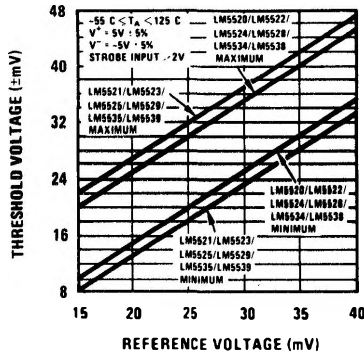


voltage waveforms

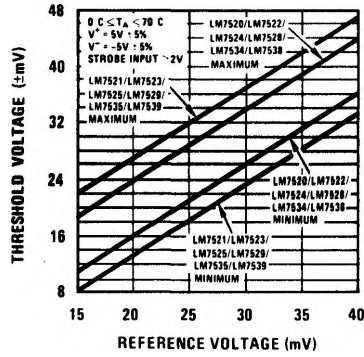


guaranteed performance

Differential Input Threshold Voltage

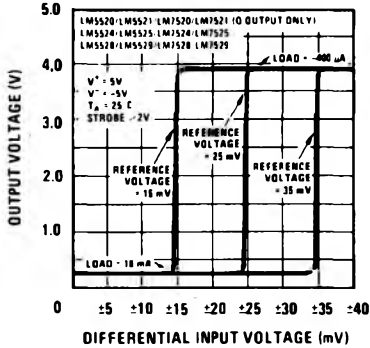


Differential Input Threshold Voltage

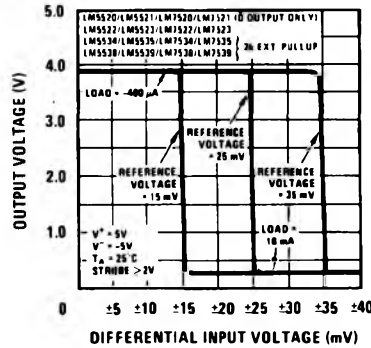


typical performance

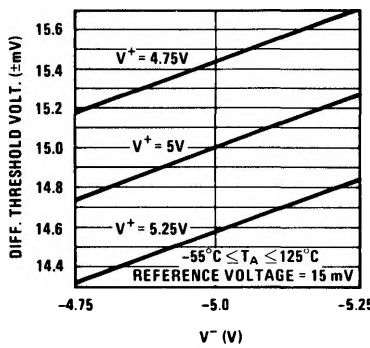
Transfer Characteristics



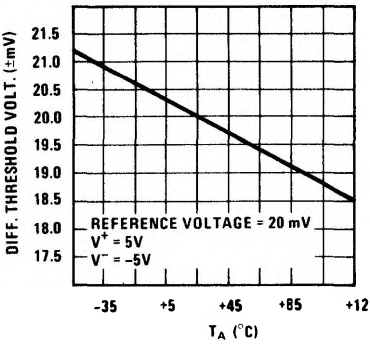
Transfer Characteristics



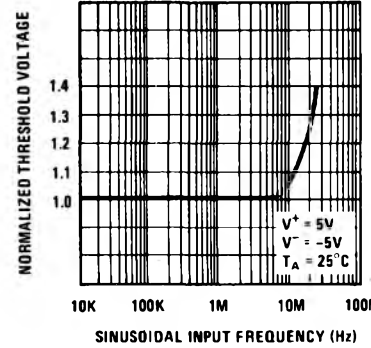
Power Supply Rejection



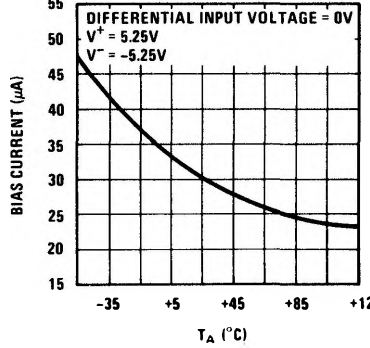
Temperature Coefficient



Differential Input Frequency Response

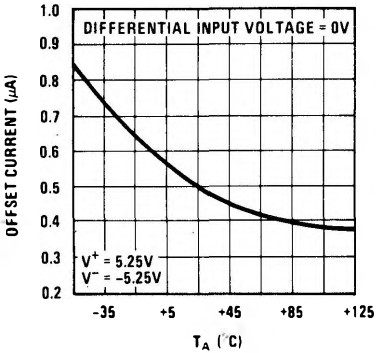


Differential Input Bias Current

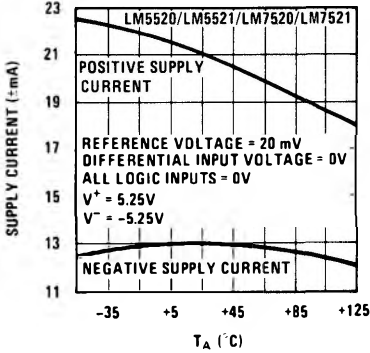


typical performance (cont.)

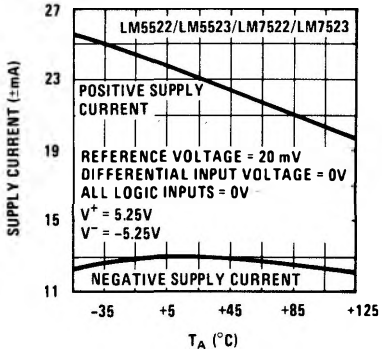
Differential Input Offset Current



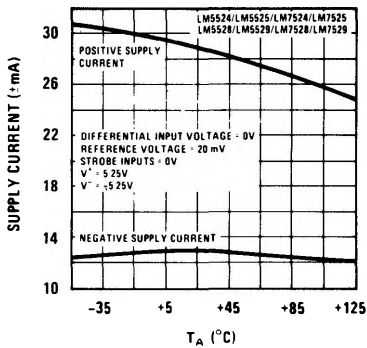
Power Supply Currents



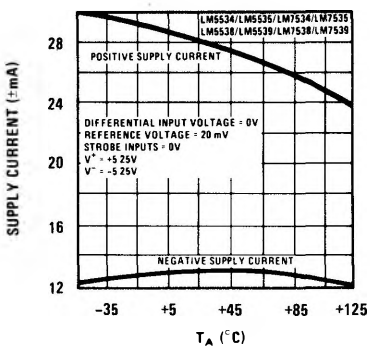
Power Supply Currents



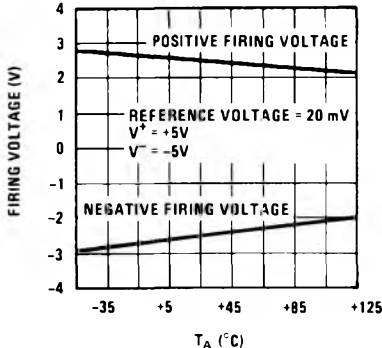
Power Supply Currents



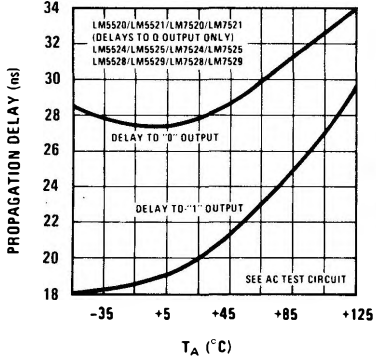
Power Supply Currents



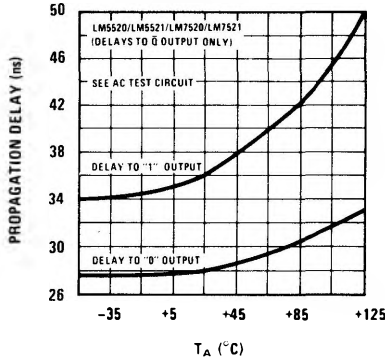
AC Common-Mode Firing Voltage



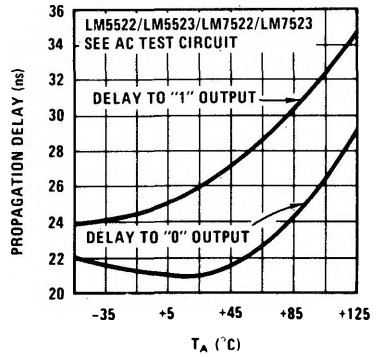
Differential Input to Output Propagation Delays



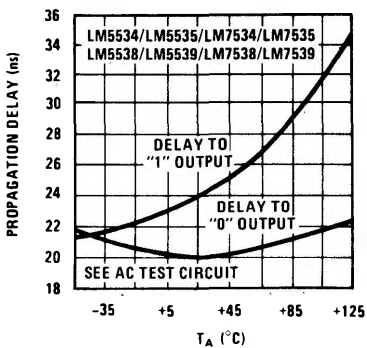
Differential Input to Output Propagation Delays



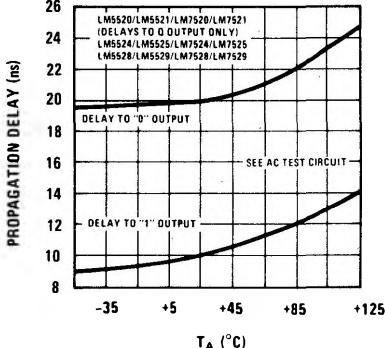
Differential Input to Output Propagation Delays



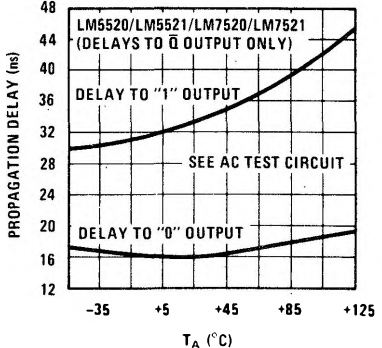
Differential Input to Output Propagation Delays



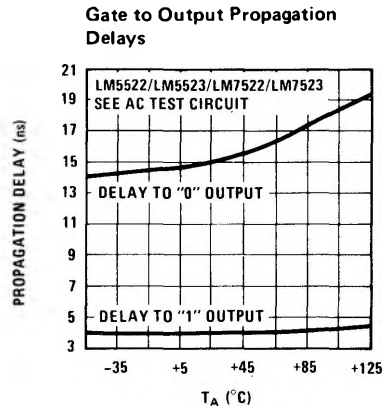
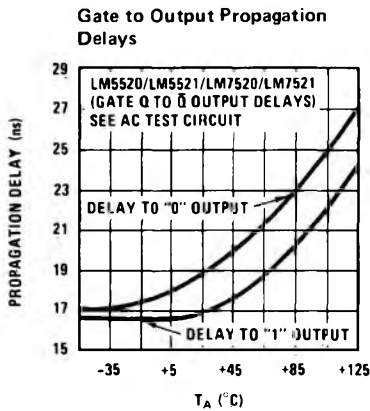
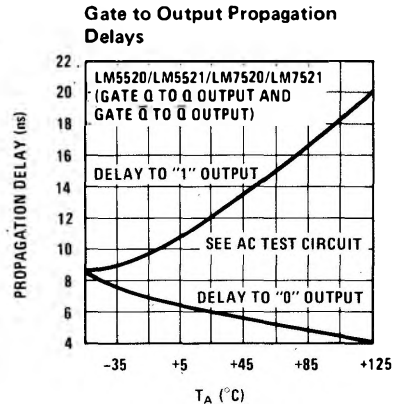
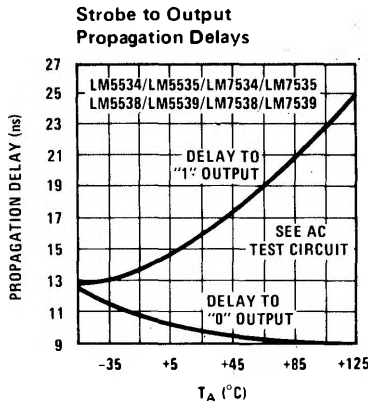
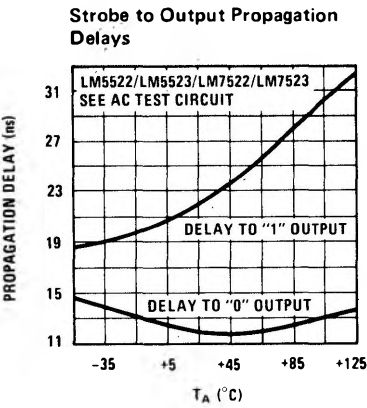
Strobe to Output Propagation Delays



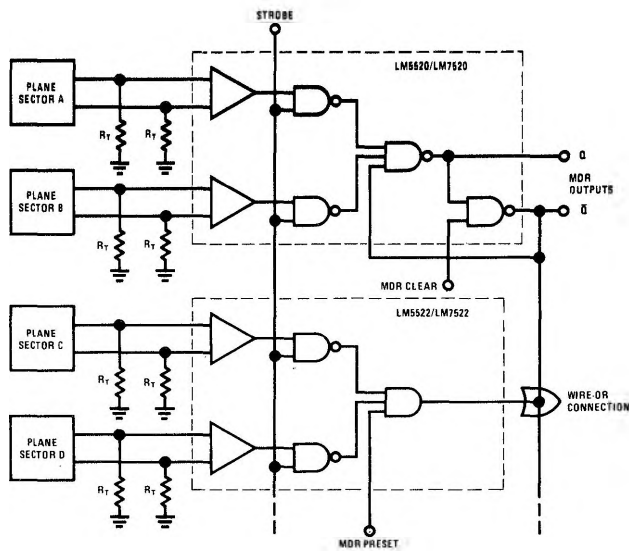
Strobe to Output Propagation Delays



typical performance (cont.)

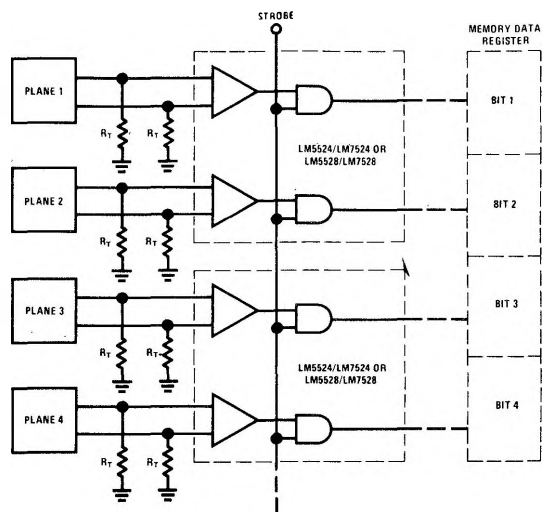


typical applications

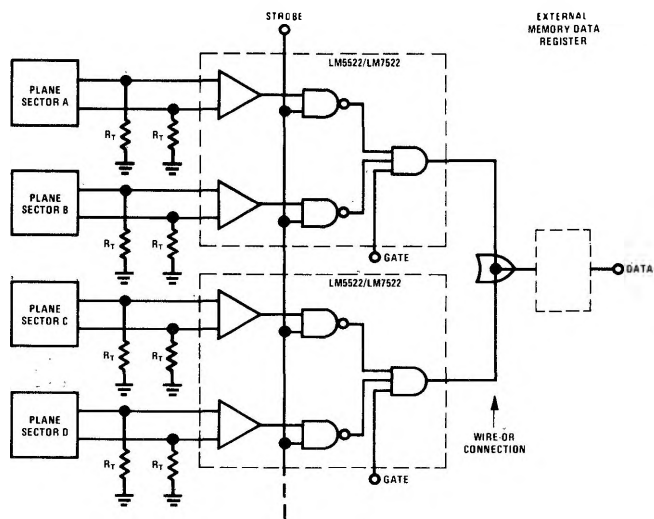


Large Memory System with Sectored Core Planes

typical applications (cont.)



Small Memory System



Large Memory System